AKM Clearance/Creepage 8mm CZ-3701 60Arms Accurate Coreless Current Sensor

1. General Description

CZ-3701 is an open-type current sensor using Hall sensors, which outputs the analog voltage proportional to the AC/DC current. Group III-V semiconductor thin film is used as the Hall sensor, which enables the high-accuracy and high-speed current sensing. Coreless ultra-small surface mount package realizes the space-saving. Also, the low primary conductor resistance suppresses heat generation to achieve the 60Arms continuous current. Existing coreless current sensors have an accuracy disadvantage from degradations caused by a disturbed magnetic field. The CZ-370x series has a built-in stray magnetic field reduction function to suppress this effect. The CZ-370x series is also UL 61800-5-1 safety compliant, which is an excellent fit for industrial AC drives, servo motors, etc. The CZ-370x series has a large variety of linear measurement ranges, from ±5.3A (CZ-3700), to ±180A, (CZ-3706). This enables the designer to use the same board design across different products and helps the user to expand the options to different current ratings.

2. Features

- \Box Compliant with safety standard of UL61800-5-1 (Clearance, Creepage distance \geq 8.0mm)
- Certified with safety standards of UL-1577 and IEC/UL62368-1.
- □ Maximum Primary Current : 60A_{rms}
- □ High-accuracy : ±0.4%F.S.(T_a=0~90°C Typ.)
- \Box Quite small primary conductor resistance : 0.27m Ω Typ.
- □ Fast response time : 1µs Typ.
- □ Stray magnetic field reduction function
- □ Small-sized surface mount package (12.7mm×10.9mm×2.25mm)
- Differential output with VREF pin
- □ Isolation Voltage : 3.0kV (AC50Hz, 60s)
- □ Ratiometric output



3. Applications

□ AC motors

DC motors

□ UPS

□ General Inverters

Power conditioners

Also, CZ-3701 is suitable for other applications which are required isolation with small size and suppressing heat generation.

4. Table of Contents

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5. Block Diagram and Functions

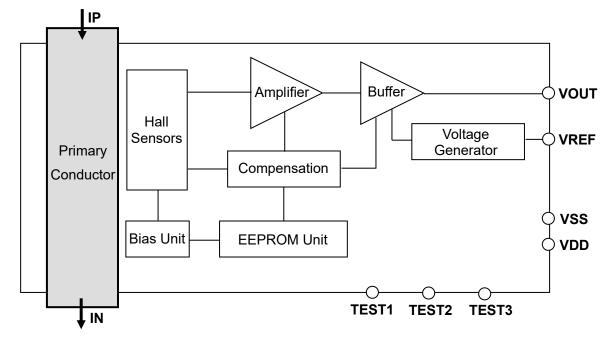


Figure 1. Block diagram of CZ-3701

Table 1.	Explanation of circuit blocks
	Expland of the of the of the

Circuit Block	Function		
Primary Conductor	A device has the primary conductor built-in.		
Hall elements which detect magnetic flux density generated from t measured current.			
Amplifier	Amplifier of Hall elements' output.		
Buffer Output buffer with gain. This block outputs the voltage (Vol proportional to the current applied to the primary conductor.			
Compensation	Compensation circuit which adjusts the temperature drifts of sensitivity and zero-current voltage.		
Bias Unit	Drive circuit for Hall elements.		
EEPROM Unit	Non-volatile memory for setting adjustment parameters.		
Voltage Generator	Reference voltage generating circuit of VOUT.		

6. Pin Configurations and Functions

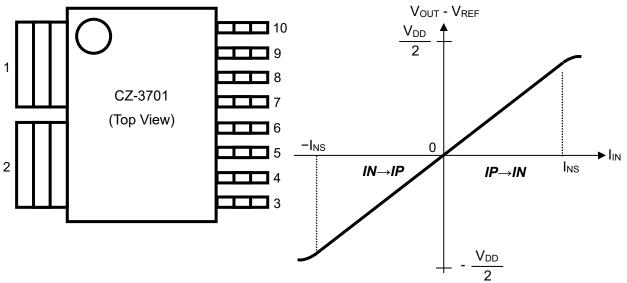


Figure 2. Pin configurations and typical output characteristics of CZ-3701

Pin No.	Pin Name	I/O	Туре	Function
1	IP	I	_	Primary conductor pin (+)
2	IN		—	Primary conductor pin (-)
3	VSS	GND	Power	Ground pin (GND)
4	TEST1	_	—	Test pin (Recommended external connection : GND)
5	VREF	0	Analog	Reference output pin
6	VOUT	0	Analog	Sensor output pin
7	VDD	PWR	Power	Power supply pin (5V)
8	TEST2		_	Test pin (Recommended external connection : OPEN)
9	TEST3			Test pin (Recommended external connection : OPEN)
10	VSS	GND	Power	Ground pin (GND)

Table 2.	Pin configuration and functions of CZ-3701
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7. Absolute Maximum Ratings

				-	
Parameter	Symbol	Min.	Max.	Units	Notes
Supply Voltage	V _{DD}	-0.3	6.5	V	VDD pin
Analog Output Current	lout	-10	10	mA	VOUT pin, VREF pin
Junction Temperature	Tj	-40	150	°C	
Storage Temperature	T _{STG}	-40	150	°C	

Table 3.	Absolute	maximum	ratings

WARNING:

Operation at or beyond these limits may result in permanent damage to the device. Normal operation is not guaranteed at these extremes.

8. Recommended Operating Conditions

Table 4. Recommended operating conditions							
Parameter	Symbol	Min.	Тур.	Max.	Units	Notes	
Supply Voltage	V _{DD}	4.5	5.0	5.5	V	VDD pin	
Sensor Output Load Capacitance 1	CLVOUT			1000	pF	Between VOUT pin and VSS pin	
Reference Output Load Capacitance 2	CLVREF			1000	pF	Between VREF pin and VSS pin	
Sensor Output Load Resistance 1	RLVOUT	3			kΩ	Between VOUT pin and VSS pin Between VOUT pin and VDD pin	
Reference Output Load Resistance 2	R _{LVREF}	3			kΩ	Between VREF pin and VSS pin Between VREF pin and VDD pin	
Operating Ambient Temperature	Ta	-40		105	°C		
Case Temperature Note 1)	Tc	-40		130	°C	Compliant with safety standard of UL61800-5-1	
Maximum Primary Current (RMS)	I _{RMSmax}			60	A _{rms}	Continuous DC value or RMS value which can be applied to primary conductor	

 Table 4. Recommended operating conditions

WARNING:

Electrical characteristics are not guaranteed when operated at or beyond these conditions. Thermal Resistance junction to ambient θ_{ja} is described in '9. Electrical Characteristics'.

Note1. Continuous 60A_{rms} current can be flowed through this IC, and even a larger current can be flowed transiently. Using as your system complied with safety standard of UL61800-5-1, the case temperature of this IC should be less than 130°C.

[CZ-3701]

9. Electrical Characteristics

•		ied) : T _a =25°C, V _{DD} =5V				
Parameter	Symbol	Conditions	Min.	Тур.	Max.	Units
Current Consumption	I _{DD}	I _{IN} =0A, No loads		20	25	mA
Sensitivity Note 2)	V _h	I _{IN} =±10A (≦5A 1ms, >5A 500μs) V _h =(V _{OUT} -V _{REF})/1A	198	200	202	mV/A
Zero-Current Output Note 2)	V_{of}	$I_{IN}=0A, V_{OUT}-V_{REF}$	-0.02		0.02	V
Reference Output Voltage Note 6)	V _{REF}		0.5×V _{DD} -0.02	0.5×V _{DD}	0.5×V _{DD} +0.02	V
Linear Sensing Range Note 3)	I _{NS}		-10.7		10.7	А
Output Saturation Voltage H Note 4)	V _{satH}	R _{LVOUT} =3kΩ	V _{DD} -0.3			V
Output Saturation Voltage L Note4)	V _{satL}	R _{LVOUT} =3kΩ			0.3	V
Linearity Error Note 5) Note 6)	ρ	T _a =-40~105°C F.S.=V _{satH} -V _{satL}		±0.20	±0.28	%F.S.
Rise Response Time Note 4)	tr	I _{IN} 90% to V _{OUT} 90%, C _{LVOUT} = C _{LVREF} =1000pF		1		μs
Fall Response Time Note 4)	t _f	I _{IN} 10% to V _{OUT} 10%, C _{LVOUT} = C _{LVREF} =1000pF		1		μs
Input Current Equivalent Noise	I _{Nrms}	I _{IN} =0A ,DC~400kHz		30		mA _{rms}
Ratiometric Error of Sensitivity	V _{h-R}	V _{DD} =4.5V~5.5V	-1.0		1.0	%
Ratiometric Error of Zero-Current Output	V _{of-R}	V _{DD} =4.5V~5.5V I _{IN} =0A	-0.3		0.3	%F.S.
Stray Magnetic Field Reduction	E _{bc}	Equivalent to Zero-Current output drift -10mT < Stray Magnetic Field <10mT		0.01		A/mT
dV/dt Settling Time Note 4) Note 7)	t _{d∨dt}	200V/µs 200V		2		μs
Primary Conductor Resistance Note 3)	R _P	T _c =25°C		0.27		mΩ
Thermal Resistance junction to ambient	θ _{ja}	Board Layout is Figure 7. ΔT=R _p ×I _{IN} ²×θ _{ja} /1000		32		°C/W
Isolation Voltage Note 8)	VINS	AC50Hz, 60s	3.0			kV _{rms}
Isolation Resistance Note 3)	R _{INS}	DC1kV	500			MΩ
Retention Time of EEPROM data	EEP _{RT}	T _j < 105°C	10			Year

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Units
Temperature Drift of		T _a =0~90°C	-0.6	0.3	0.7	
Sensitivity	V_{h-d}	T _a =0~105°C	-0.6	0.7	1.2	%
Note 5) Note 6) Note 9)		T _a =-40~105°C	-1.3	0.7	1.2	
Temperature Drift of		T _a =0~90°C I _{IN} =0A		±1.8	±4.0	
Zero-current Output	$V_{\text{of-d}}$	T _a =0~105°C I _{IN} =0A		±2.0	±5.2	mV
Note 5) Note 6) Note 9)		T _a =-40~105°C I _{IN} =0A		±7.2	±10.4	
Temperature Drift of						
Reference Output	V_{REF} -d	T _a =-40~105°C		±10		mV
Note 6) Note 9)						
		T _a =0~90°C	-0.7	±0.4	0.5	
		F.S.=V _{satH} -V _{satL}	0.1	±0.4	0.0	
Total Accuracy	E _{total}	T _a =0~105°C	-0.7	±0.4	0.6	%F.S.
Note 5) Note 6)	Liotai	F.S.=V _{satH} -V _{satL}	0.7	10.4	0.0	/01.0.
		T _a =-40~105°C	0.9	±0.5	1.0	
		F.S.=V _{satH} -V _{satL}	0.0	±0.0	1.0	

Table 6. Temperature drift characteristics

Conditions (unless otherwise specified) \therefore V_{DD}=5V

Note 2) These values can be drifted by long-term use or reflow process. Please check '14.Reliability Tests' for the reference of drift values.

Note 3) These parameters are guaranteed by design.

Note 4) These parameters are tested in wafer condition.

Note 5) The Typical value is defined as the "average value $\pm 1\sigma$ " of the actual measurement result in a certain lot. The minimum value and the maximum value are defined as "average value $\pm 3\sigma$ " of the same condition.

Note 6) These values can be drifted by long-term use or reflow process.

Note 7) The threshold level of the dV/dt settling time is the convergence value ± 5 mV.

Note 8) This parameter is tested for 1second at 3.6kV_{rms} in mass-production line for all devices.

Note 9) These parameters are defined as the drift from the values at $T_a=25^{\circ}C$.

10. Characteristic Definitions

10.1. Sensitivity(V_h), Zero-Current Output (V_{of}), and Linearity Error (ρ) are defined as below:

Sensitivity(V_h) is defined as the slope of the approximate straight line calculated by the least square method, using the data of output voltage (V_{OUT} -V_{REF}) when the primary current (I_{IN}) is swept within the range of linear sensing range (I_{NS}).

The output voltage ($V_{OUT} - V_{REF}$) when the primary current (I_{IN}) is 0A is the Zero-Current Output (V_{of}).

Linearity Error (ρ) is defined as the ratio of the maximum error voltage (V_d) to the full scale (F.S.), where V_d is the maximum difference between the output voltage (V_{OUT} -V_{REF}) and the approximate straight line. Definition formula is shown as below:

 $\rho = V_d / F.S. \times 100$

Full scale (F.S.) is defined by V_{satHmin} - V_{satLmax}.

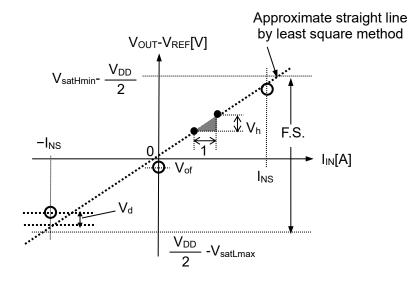


Figure 3. Characteristic definitions of CZ-3701

10.2. Ratiometric Error of Sensitivity is defined as below:

$$V_{h-R} = 100 \times \frac{\left\{\frac{V_h(V_{DD})}{V_h(5V)} - \frac{V_{DD}}{5}\right\}}{\frac{V_{DD}}{5}}$$

10.3. Ratiometric Error of Zero-Current Output is defined as below:

$$V_{of-R} = 100 \times \frac{\left(V_{of}(V_{DD}) - \frac{V_{of}(5V) \times V_{DD}}{5}\right)}{F.S.}$$

10.4. Total Accuracy E_{total} [%F.S.] is defined as below:

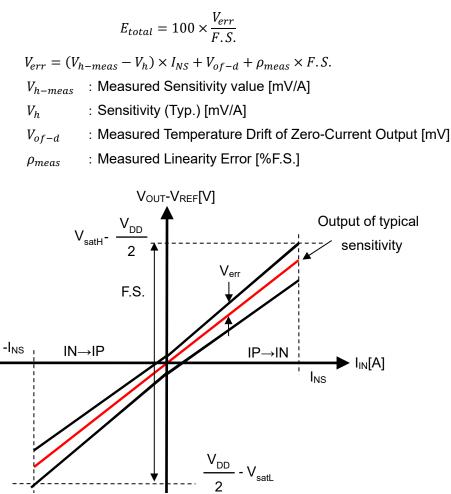
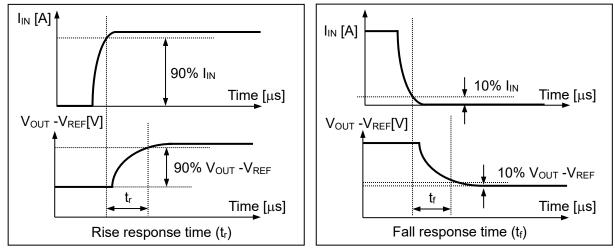
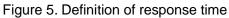


Figure 4. Total Accuracy of CZ-3701

10.5. Rise Response Time t_r [µs] and Fall Response Time t_f [µs]

Rise response time (or fall response time) is defined as the time delay from the 90% (or 10%) of input primary current (I_{IN}) to the 90% (or 10%) of the output voltage (V_{OUT} - V_{REF}) under the pulse input of primary current (Figure 5).





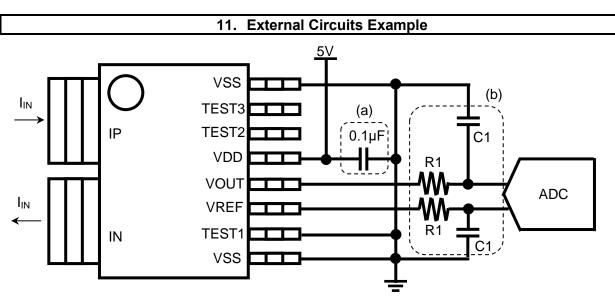


Figure 6. External circuits example

(a) 0.1 μ F bypass capacitor should be placed close to CZ-3701.

(b) Add a low-pass filter if it is necessary. The C1 values should be fixed in consideration of load conditions.

12. Board Layout for measuring thermal resistance

Table 7. Board information

Board Size	68.58mm×63.5mm
Layer number	4
Copper layer thickness	70µm
Board Thickness	1.6mm

Top pattern(1st)
 Inner pattern(2nd/3rd VSS)
 Bottom pattern(4th)

Figure 7. Board layout for measuring thermal resistance of CZ-3701

Clearance distance Cl 8.0

Symbol

Cr

*Flammability standard is V0. (According to UL94)

*Comparative tracking index (CTI) is 400V. Material Group is II.

The tolerances of dimensions without any mention are ±0.1mm.

Figure 8. Outline dimensions of CZ-3701

Table 8. Isolation characteristics of CZ-3701

Т<u>ур</u>.

Max.

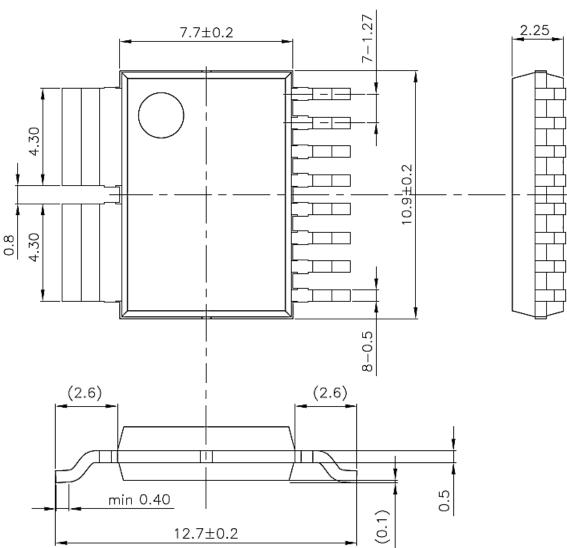
Units

mm

mm

Min.

8.0



Package

13.

13.1. Outline Dimensions

Unit : mm

Terminals : Cu

Plating for Terminals : Sn-Bi

Parameter

Creepage distance

() is a reference values.

Package material : RoHS compliant, halogen-free

13.2. Standards

• IEC/UL 62368-1 Audio/video, information and communication technology equipment Part 1: Safety requirements Edition 2. (File No. E359197)

• CSA C22.2 No.62368-1-14 Audio/video, information and communication technology equipment Part 1: Safety requirements Edition 2. (File No. E359197)

• UL1577-Non-optical Isolators-Edition 5.(File No. E499004)

• CSA Component Acceptance Service No. 5A - Component Acceptance Service for Optocouplers and Related Devices (File No. E499004)

13.3. Recommended Pad Dimensions

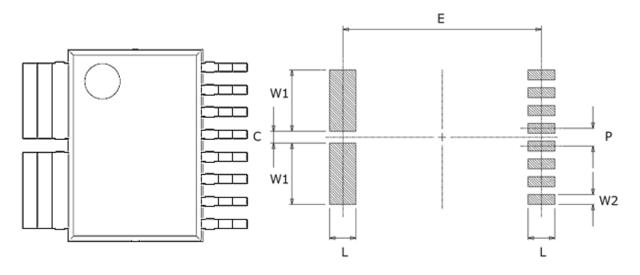


Figure 9. Recommended pad pattern

L	1.59
Е	11.79
W1	4.44
W2	0.64
С	0.66
Р	1.27

Unit:mm

If two or more trace layers are used as the current paths, please make enough number of through-holes to flow current between the trace layers. In order to make heat dissipation better, it is recommended that Pad on Via should be provided on the pad of the primary conductor.

[CZ-3701]

13.4. Marking

Production information is printed on the package surface by laser marking. Markings consist of 11 characters excluding AKM logo.

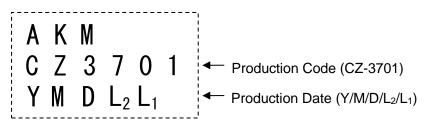


Figure [•]	10. Markings	of CZ-3701
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			Table 10. Pro	duction date	code tabl				
Year(Y)		Month(M)		Day(Day(D)		Lot number		
Character	Year	Character	Month	Character	Day	Character (L ₂)	Character (L ₁)	Lot number	
7	2017	С	January	1	1	0	1	01	
8	2018	D	February	2	2	0	2	02	
9	2019	E	March	3	3	0	3	03	
А	2020	F	April	4	4	0	4	04	
В	2021	G	May	5	5	0	5	05	
С	2022	Н	June	6	6	:			
D	2023	J	July	7	7	-		:	
E	2024	K	August	8	8	6	7	67	
F	2025	L	September	9	9	6	8	68	
G	2026	M	October	0	10	6	9	69	
Н	2027	N	November	A	11	7	0	70	
J	2028	Р	December	В	12	7	1	71	
K	2029			С	13				
L	2030			D	14		:		
Ν	2031			E	15				
Р	2032	1		F	16				
R	2033	1		G	17				
S	2034	1		Н	18				
Т	2035	1		J	19				
U	2036			K	20				
V	2037	1		L	21				
W	2038	1		N	22				
Х	2039	1		Р	23				
0	2040	1		R	24				
1	2041	1		S	25				
2	2042	1		Т	26				
3	2043	1		U	27				
4	2044	1		V	28				
		-		W	29				
				Х	30				

Y

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14. Reliability Tests

No.	Test Parameter Test Conditions		n	Test Time
1	Temperature Humidity Bias Test	【JEITA EIAJ ED-4701 102】 T _a =85°C, 85%RH, continuous operation		500h
2	High Temperature Bias Test	【JEITA EIAJ ED-4701 101】 T _a =150°C, continuous operation		500h
3	High Temperature Storage Test 【JEITA EIAJ ED-4701 201】 Ta=150°C		22	500h
4	Low Temperature Operating Test	T_a =-40°C, continuous operation	22	500h
5	Heat Cycle Test	【JEITA EIAJ ED-4701 105】 −65°C⇔ +150°C 30min.⇔ 30min. Tested in vapor phase	22	200 Cycles

Table 11. Test parameters and conditions of reliability tests

Tested samples are pretreated as below before each reliability test:

Desiccation: $125^{\circ}C/24h \rightarrow Moisture Absorption: 60^{\circ}C/60\% RH/168h$

 \rightarrow Reflow: 3 times (JEDEC Level2a)

Criteria:

Products whose drifts between before pretreated and after the reliability tests do not exceed the values below are considered to be in spec.

Sensitivity V _h (T _a =25°C)	: Within ±1.5%
Zero-Current Output Vof (Ta=25°C)	: Within ±25mV
Linearity Error ρ (T _a =25°C)	: Within ±0.5%F.S.
EEPROM data	: Unchanged

15. Precautions

<Storage Environment>

Products should be stored at an appropriate temperature, and at as low humidity as possible by using desiccator (5 to 35°C). It is recommended to use the products within 4 weeks since packing was opened. Keep products away from chlorine and corrosive gas. When stored in an inappropriate environment, it can affect the product properties.

<Long-term Storage>

Long-term storage may result in poor lead solderability and degraded electrical performance even under proper conditions. For those parts, which stored long-term should be checked as for solderability before it is used.

For storage longer than 1 year, it is recommended to store in nitrogen atmosphere. Oxygen of atmosphere oxidizes leads of products, and lead solderability get worse.

<Other Precautions>

1) This product should not be used under the environment with corrosive gas including chlorine or sulfur.

2) This product is lead (Pb) free. All leads are plated with Sn-Bi. Do not store this product alone in high temperature and high humidity environment. Moreover, this product should be mounted on substrate within six months after delivery.

3) This product is damaged when it is used on the following conditions:

- Supply voltage is applied in the opposite way.

- Overvoltage which is larger than the value indicated in the specification.

4) This product will be damaged if it is used for a long time with the current (effective current) which exceeds the current rating. Careful attention must be paid so that maximum effective current is smaller than current rating.

5) The characteristics can be changed by the influences of nearby current and magnetic field and electric field. Please make sure of the mounting position.

As this product contains gallium arsenide, observe the following procedures for safety.

1) Do not alter the form of this product into a gas, powder, liquid, through burning, crushing, or chemical processing.

2) Observe laws and company regulations when discarding this product.

16. Revision History

Date (Y/M)	Revision	Page	Contents
August, 2018	00	16	
November, 2021	01	17	-Acquisition of successor standards due to revision of safety standards. -Revised specifications values.

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